Application/Control No. 10/065,168 Application/Control No. 10/065,168 Application(s)/Patent Under Reexamination ROEHR ET AL. Examiner Viet Q Nguyen Art Unit Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2003/0095457	05-2003	Jeon et al.	365/205
*	В	US-6236588	05-2001	Коо	365/145
*	С	US-6215692	04-2001	Kang	365/145
*	D	US-2003/0031059	02-2003	Endo et al.	365/189.09
*	Е	US-6538915	03-2003	Endo et al	365/145
*	F	US-6,411,540	06-2002	Ashikaga, Kinya	365/145
*	G	US-5086412	02-1992	Jaffe et al	365/145
*	Н	US-6,188,601	02-2001	Kim et al.	365/145
	1	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	JP02000348484A	12-2000	Japan	Kin et al	G11C 11/22
	0					
	Ρ					
	σ					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	Viet Q. Nguyen Primary Examiner
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.